

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/751,483	NAGAHAMA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Sonny TRINH	2618	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0022229	02-2004	Vanness, Philip H.	370/343
*	B	US-6,466,776	10-2002	Okanobu, Taiwa	455/343.2
*	C	US-2004/0261132	12-2004	Shimizu, Yasuhiro	725/139
*	D	US-2005/0020220	01-2005	Gamou, Yoshitsugu	455/132
*	E	US-2005/0113049	05-2005	Takayama et al.	455/150.1
*	F	US-2005/0232431	10-2005	Kato, Takeshi	381/002
*	G	US-2005/0272385	12-2005	Nagano et al.	455/143
*	H	US-6,005,894	12-1999	Kumar, Derek D.	375/270
*	I	US-6,351,500	02-2002	Kumar, Derek D.	375/270
*	J	US-6,813,310	11-2004	Okanobu, Taiwa	375/216
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.